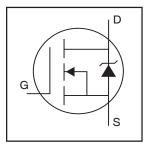
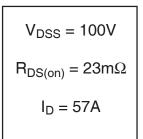
International Rectifier

IRF3710

HEXFET® Power MOSFET

- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated





Description

Advanced HEXFET® Power MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.



Absolute Maximum Ratings

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V 57		
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	40	Α
I _{DM}	Pulsed Drain Current ①	230	
P _D @T _C = 25°C	Power Dissipation	200	W
	Linear Derating Factor	1.3	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
I _{AR}	Avalanche Current①	28	А
E _{AR}	Repetitive Avalanche Energy ^①	20	mJ
dv/dt	Peak Diode Recovery dv/dt ③	5.8	V/ns
T_J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting torque, 6-32 or M3 srew	10 lbf•in (1.1N•m)	

Thermal Resistance

	Parameter	Тур.	Max.	Units
R _{θJC}	Junction-to-Case		0.75	
R _{θCS}	Case-to-Sink, Flat, Greased Surface	0.50		°C/W
$R_{\theta JA}$	Junction-to-Ambient		62	

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.13		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			23	mΩ	V _{GS} = 10V, I _D =28A ④
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
9fs	Forward Transconductance	32			S	V _{DS} = 25V, I _D = 28A⊕
I	Drain-to-Source Leakage Current			25	μA	V _{DS} = 100V, V _{GS} = 0V
I _{DSS}	Brain to Godice Edunage Guiterit			250	μΛ	$V_{DS} = 80V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
lasa	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 20V
I _{GSS}	Gate-to-Source Reverse Leakage			-100		V _{GS} = -20V
Qg	Total Gate Charge			130		I _D = 28A
Q_{gs}	Gate-to-Source Charge			26	nC	$V_{DS} = 80V$
Q_{gd}	Gate-to-Drain ("Miller") Charge			43		V_{GS} = 10V, See Fig. 6 and 13
t _{d(on)}	Turn-On Delay Time		12			$V_{DD} = 50V$
t _r	Rise Time		58		ns	$I_D = 28A$
t _{d(off)}	Turn-Off Delay Time		45		115	$R_G = 2.5\Omega$
t _f	Fall Time		47			V _{GS} = 10V, See Fig. 10 ⊕
1-	Internal Drain Inductance		4.5		nH	Between lead,
L _D						6mm (0.25in.)
	Internal Source Inductance		7.5	_		from package
L _S						and center of die contact
C _{iss}	Input Capacitance		3130			$V_{GS} = 0V$
C _{oss}	Output Capacitance		410			$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		72		pF	f = 1.0MHz, See Fig. 5
E _{AS}	Single Pulse Avalanche Energy ²		1060 ଓ	280©	mJ	$I_{AS} = 28A, L = 0.70mH$

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions	
Is	Continuous Source Current			57		MOSFET symbol	
	(Body Diode)			5/	A	showing the	
I _{SM}	Pulsed Source Current		0.0		000	, ,	integral reverse
	(Body Diode)①		230		p-n junction diode.		
V _{SD}	Diode Forward Voltage			1.2	V	$T_J = 25^{\circ}C$, $I_S = 28A$, $V_{GS} = 0V$ ④	
t _{rr}	Reverse Recovery Time		140	220	ns	$T_J = 25^{\circ}C, I_F = 28A$	
Q _{rr}	Reverse Recovery Charge		670	1010	nC	di/dt = 100A/µs ④	
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)					

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- $\begin{tabular}{ll} \hline \mathbb{Q} Starting $T_J=25^\circ$C, $L=0.70mH$ \\ $R_G=25\Omega$, $I_{AS}=28A$, $V_{GS}=10V$ (See Figure 12) \\ \hline \end{tabular}$
- $\label{eq:loss} \begin{array}{l} \mbox{\Large \ \, $]} I_{SD} \leq 28A, \ di/dt \leq 380A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \\ T_{J} \leq 175^{\circ}C \end{array}$
- $\ \, \mbox{ } \mbox$
- ⑤ This is a typical value at device destruction and represents operation outside rated limits.
- $\stackrel{\cdot}{\text{\sc G}}$ This is a calculated value limited to T_J = 175°C .

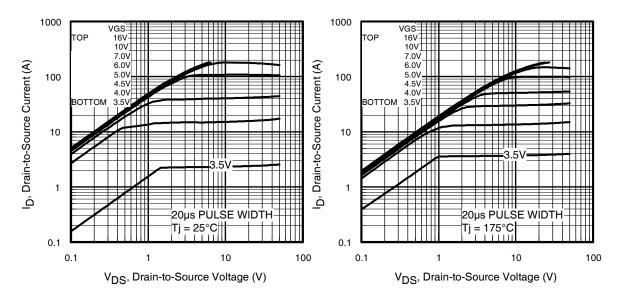


Fig 1. Typical Output Characteristics

Fig 2. Typical Output Characteristics

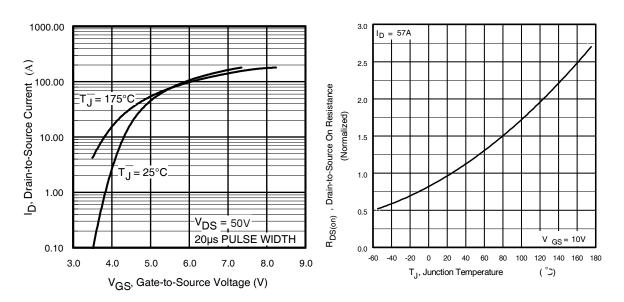


Fig 3. Typical Transfer Characteristics

Fig 4. Normalized On-Resistance Vs. Temperature

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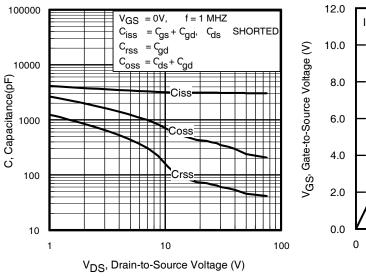


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

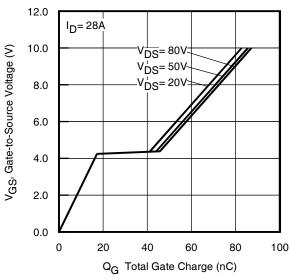


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

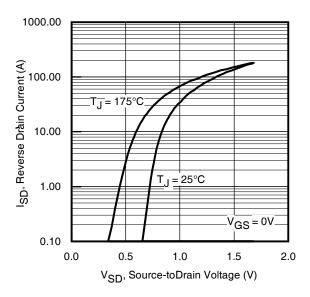


Fig 7. Typical Source-Drain Diode Forward Voltage

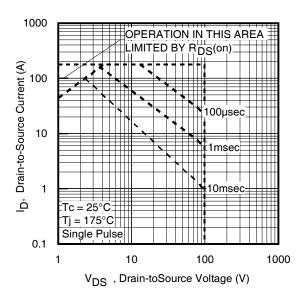


Fig 8. Maximum Safe Operating Area

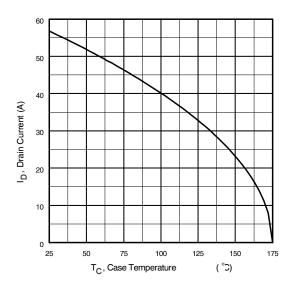


Fig 9. Maximum Drain Current Vs. Case Temperature

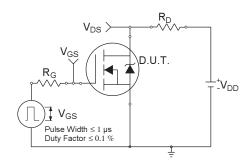


Fig 10a. Switching Time Test Circuit

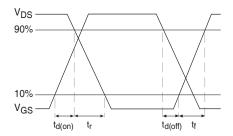


Fig 10b. Switching Time Waveforms

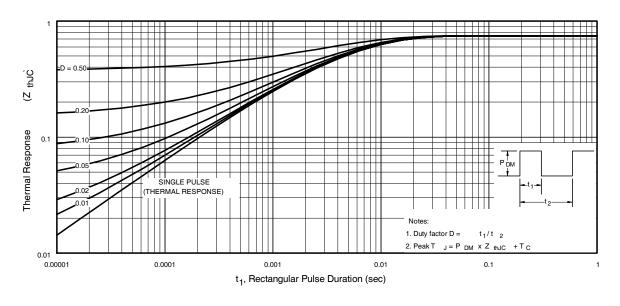


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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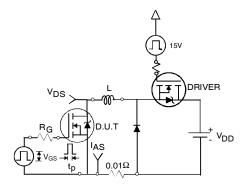


Fig 12a. Unclamped Inductive Test Circuit

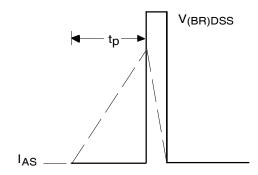


Fig 12b. Unclamped Inductive Waveforms

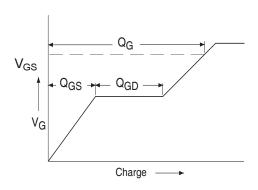


Fig 13a. Basic Gate Charge Waveform

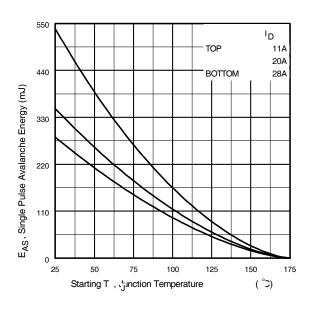


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

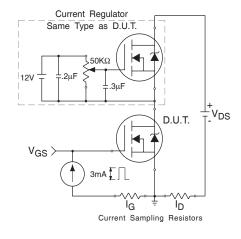
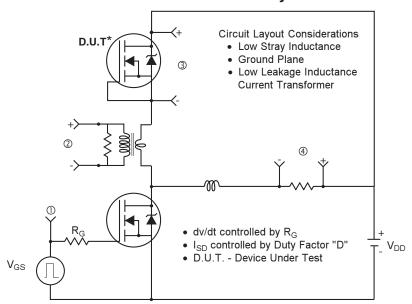
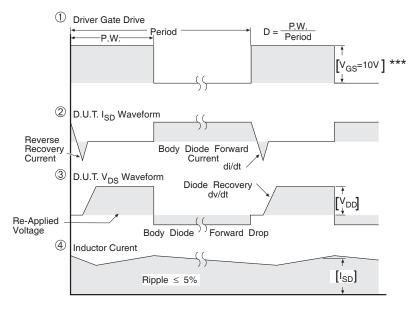


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



* Reverse Polarity of D.U.T for P-Channel



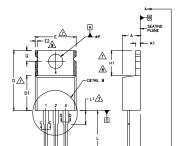
*** V_{GS} = 5.0V for Logic Level and 3V Drive Devices

Fig 14. For N-channel HEXFET® power MOSFETs

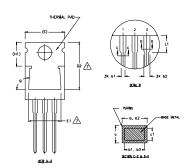
IRF3710

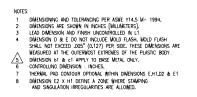
TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



-2× e -2× e -2× e -2× e -2× e





	DIMENSIONS					
SYMBOL	MILLIMETERS		INC			
	MiN.	MAX.	MIN.	MAX.	NOTES	
A	3.56	4.82	.140	.190		
A1	0.51	1.40	.020	.055		
A2	2,04	2,92	.080	.115		
b	0.38	1,01	.015	.040		
ь1	0.38	0,96	.015	,038	5	
b2	1,15	1,77	.045	.070		
b3	1,15	1,73	.045	.068		
c	0,36	0,61	.014	.024		
c1	0.36	0,56	.014	.022	5	
D	14.22	16.51	.560	.650	4	
D1	8.38	9.02	.330	.355		
D2	12.19	12.88	.480	.507	7	
E	9,66	10.66	.380	.420	4,7	
E1	8.38	8,89	.330	.350	7	
e	2,54	BSC	,100	,100 BSC ,200 BSC		
e1		5.08			-	
H1	5.85	6.55	.230	.270	7,8	
L	12,70	14,73	,500	.580		
Lf	-	6.35	-	.250	3	
øP	3,54	4,08	.139	.161		
0	2.54	3.42	.100	.135		
ø	90'-93'		90*	90'-93'		

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HEXTET 1. GATE 2. DRAIN 3. SOURCE KERTS. COPACK 1. GATE 2. COLLECTOR 3. EMITER DECOS

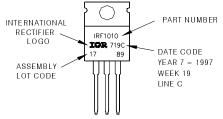
TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010

LOT CODE 1789

ASSEMBLED ON WW 19, 1997
IN THE ASSEMBLY LINE 'C'

Note: "P" in assembly line position indicates "Lead-Free"



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

Data and specifications subject to change without notice. This product has been designed and qualified for the Automotive [Q101] market.

Qualification Standards can be found on IR's Web site.



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